Power MOSFET and Schottky Diode

-20 V, FETKY[™], P-Channel, -4.4 A, with 4.1 A Schottky Barrier Diode, ChipFET[™]

Features

- Leadless SMD Package Featuring a MOSFET and Schottky Diode
- 40% Smaller than TSOP-6 Package
- Leadless SMD Package Provides Great Thermal Characteristics
- Independent Pinout to each Device to Ease Circuit Design
- Trench P-Channel for Low On Resistance
- Ultra Low V_F Schottky
- Pb-Free Packages are Available

Applications

- Li-Ion Battery Charging
- High Side DC-DC Conversion Circuits
- High Side Drive for Small Brushless DC Motors
- Power Management in Portable, Battery Powered Products

MOSFET MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Units		
Drain-to-Source Voltag	V_{DSS}	-20	V		
Gate-to-Source Voltage	е		V_{GS}	±8.0	V
Continuous Drain	Steady	$T_J = 25^{\circ}C$	I _D	-3.2	Α
Current (Note 1)	State	T _J = 85°C		-2.3	
	t ≤ 5 s T _J = 25°C			-4.4	
Power Dissipation (Note 1)	$ \begin{array}{c c} \text{pation} & \text{Steady} \\ \hline \text{State} & \\ \hline t \leq 5 \text{ s} \end{array} T_J = 25^{\circ}\text{C} $		P _D	1.1	W
				2.1	
Pulsed Drain Current	t _p =	10 μs	I _{DM}	-13	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	ô
Source Current (Body D	I _S	2.5	Α		
Lead Temperature for S (1/8" from case for 1		urposes	TL	260	°C

SCHOTTKY DIODE MAXIMUM RATINGS

(T_J = 25°C unless otherwise noted)

Parai	Symbol	Value	Units		
Peak Repetitive Rever	V_{RRM}	20	V		
DC Blocking Voltage	V_{R}	20	V		
Average Rectified Forward Current	Steady State	T _J = 25°C	ΙF	2.2	V
	t ≤ 5 s			4.1	Α

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).



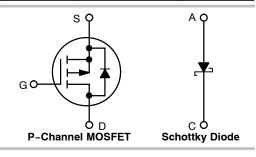
ON Semiconductor®

http://onsemi.com

MOSFET					
V _{(BR)DSS} R _{DS(on)} TYP I _D MAX					
-20 V	64 mΩ @ -4.5 V	4.4.4			
	85 mΩ @ -2.5 V	–4.4 A			

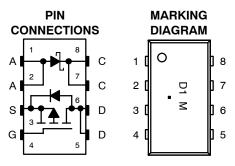
SCHOTTKY DIODE

V _R MAX	V _F TYP	I _F MAX
20 V	0.510 V	4.1 A





ChipFET CASE 1206A STYLE 3



D1 = Specific Device Code
M = Month Code
Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Units
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	113	°C/W
Junction-to-Ambient – t ≤ 10 s (Note 2)	$R_{ hetaJA}$	60	°C/W

^{2.} Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

MOSFET ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition	ıs	Min	Тур	Max	Units
OFF CHARACTERISTICS						<u>-</u>	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -25$	50 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				-15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V 16VV 0V	T _J = 25°C			-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	T _J = 125°C			-5.0	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm i$	8.0 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = -25$	50 μΑ	-0.45		-1.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				2.7		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	$V_{GS} = -4.5, I_D = -3$	3.2 A		64	80	mΩ
		$V_{GS} = -2.5$, $I_D = -2.2$ A			85	110	1
		$V_{GS} = -1.8, I_D = -1$	1.0 A		120	170	1
Forward Transconductance	9FS	V _{DS} = -10 V, I _D = -	2.9 A		8.0		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$			680		pF
Output Capacitance	Coss				100		7
Reverse Transfer Capacitance	C _{RSS}	VDS = 10 V			70		1
Total Gate Charge	Q _{G(TOT)}				7.4		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = I_D = -3.2 \text{ A}$	–10 V,		0.6		
Gate-to-Source Charge	Q_{GS}	$I_D = -3.2 \text{ A}$			1.4		
Gate-to-Drain Charge	Q_{GD}				2.5		
SWITCHING CHARACTERISTICS (No	te 4)						
Turn-On Delay Time	t _{d(ON)}				5.8		ns
Rise Time	t _r	$V_{GS} = -4.5 \text{ V}, V_{DD} =$	–10 V,		11.7		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = -3.2 \text{ A}, R_G = 2$	2.4 Ω		16		1
Fall Time	t _f				12.4		<u> </u>
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_S = -2.5 \text{ A}$	T _J = 25°C		-0.8	-1.2	V
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } I_{S} = -1.0 \text{ A ,}$ $dI_{S}/dt = 100 \text{ A/}\mu\text{s}$			13.5		ns
Charge Time	ta				9.5		1
Discharge Time	t _b				4.0		1
Reverse Recovery Charge	Q _{RR}				6.5		nC

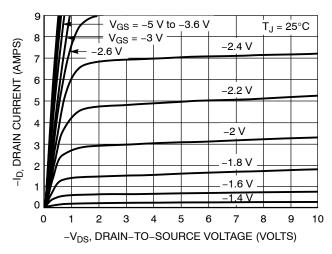
SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Maximum Instantaneous	V _F	I _F = 0.1 A		0.425		V
Forward Voltage		I _F = 1.0 A		0.510	0.575	
Maximum Instantaneous	I _R	V _R = 10 V			1.0	μΑ
Reverse Current		V _R = 20 V			5.0	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL P-CHANNEL PERFORMANCE CURVES

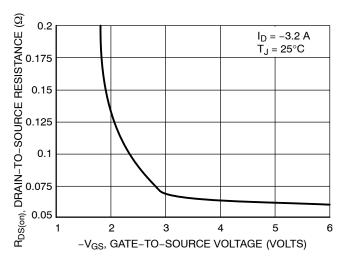
(T_J = 25°C unless otherwise noted)



 $V_{DS} \ge -10 \text{ V}$ 8 ID, DRAIN CURRENT (AMPS) 7 6 5 3 $T_C = -55^{\circ}C$ 2 25°C 100°C 0 2.5 0 0.5 2 3.5 1.5 -V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



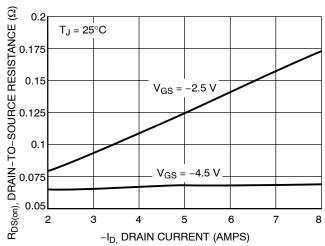
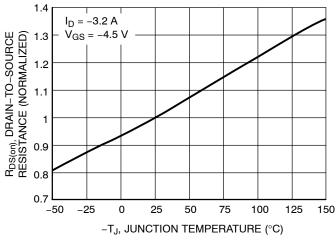


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



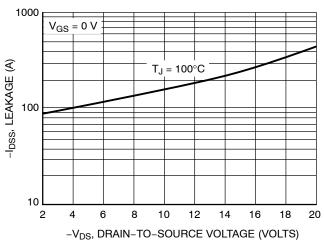
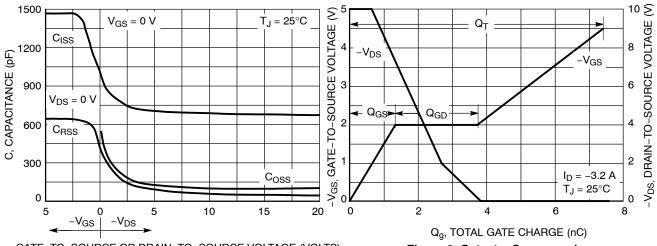


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL P-CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

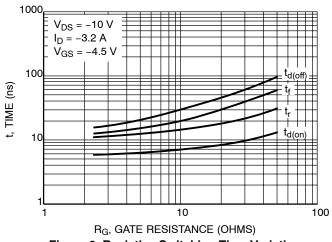


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

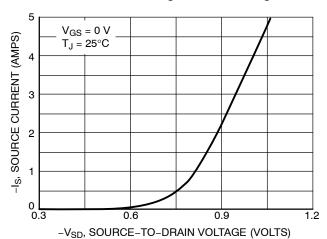
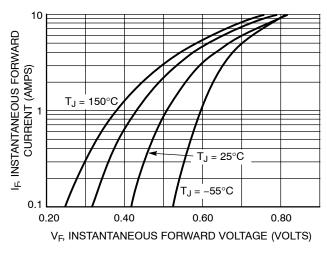


Figure 10. Diode Forward Voltage vs. Current

TYPICAL SCHOTTKY PERFORMANCE CURVES (T_J = 25°C unless otherwise noted)



OLTAGE (VOLTS)

Figure 11. Typical Forward Voltage

Figure 12. Maximum Forward Voltage

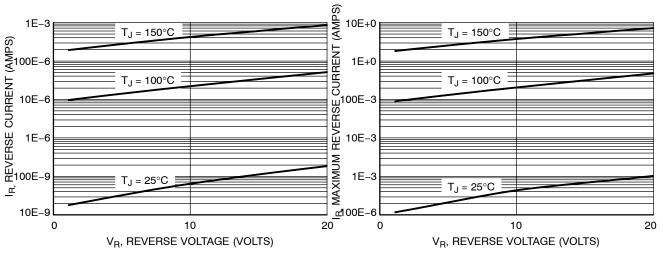
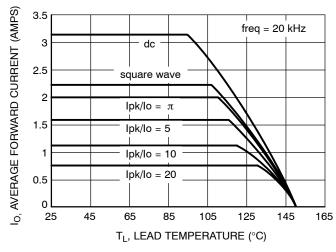
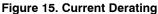


Figure 13. Typical Reverse Current

Figure 14. Maximum Reverse Current





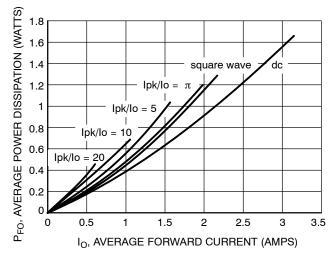


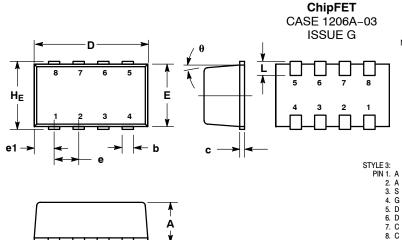
Figure 16. Forward Power Dissipation

DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTHD3101FT1	ChipFET	3000 / Tape & Reel
NTHD3101FT1G	ChipFET (Pb-Free)	3000 / Tape & Reel
NTHD3101FT3	ChipFET	10000 / Tape & Reel
NTHD3101FT3G	ChipFET (Pb-Free)	10000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



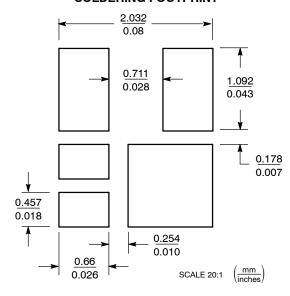
0.05 (0.002)

NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	1.00	1.05	1.10	0.039	0.041	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
С	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
E	1.55	1.65	1.70	0.061	0.065	0.067
е	0.65 BSC				0.025 BSC	;
e1	0.55 BSC				0.022 BSC)
L	0.28	0.35	0.42	0.011	0.014	0.017
HE	1.80	1.90	2.00	0.071	0.075	0.079
θ	5° NOM 5° NOM					

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D

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